

# Scintillation detector based on InAs quantum dots in a GaAs semiconductor matrix for charged particle tracking

or

## can one build a tracker out of scintillating wafers ?

S.Oktyabrsky<sup>1</sup>, M.Yakimov<sup>1</sup>, V.Tokranov<sup>1</sup>, K.Dropiewsky<sup>1</sup>, A.Minns<sup>1</sup>, M.Chattoraj<sup>2</sup>, C.Gingu<sup>3</sup>, S.Los<sup>3</sup>, P.Murat<sup>3</sup>

<sup>1</sup>SUNY Polytechnic Institute, Albany, <sup>2</sup>UIUC, <sup>3</sup>Fermilab

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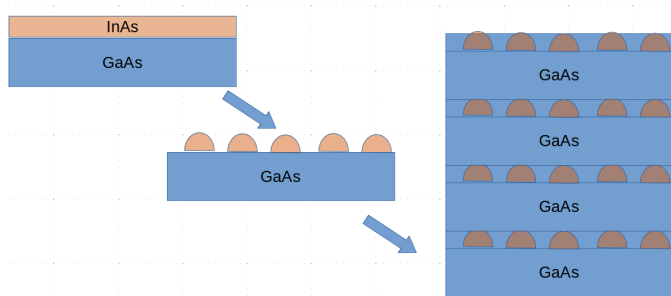
## Why quantum dots?

**if only Mu2e had a low-mass solid state tracker with the TOF resolution of 100 ps ...**

- is it possible to build a tracker based on scintillating sensors?
  - ▶ collect photons, not drifting electrons - the detector could be much faster
  - ▶ not fibers - too long travel, too much material, - but planar ones ?
- the scintillator would need to have very high light yield, fast emission
- semiconductor-based scintillators ?  $N_{\text{ph}}/\text{MeV} \sim 1e6/1.8 \cdot E_{\text{gap}} \sim (2 - 2.5)10^5$
- semiconductor quantum dots (QDs) are excellent and fast emitters with  $\tau_{\text{rad}} \sim 1\text{ns}$
- have very limited use in HEP, mostly - wavelength shifting
  - ▶ making an efficient QD-based scintillator is a problem to solve
- how to make a scintillator out of QD's, how to read it out
- what happens when you start reading it out - first results
- a concept of tracking sensor with properties quite different from Si sensors

## How to make a dense material with embedded QDs ?

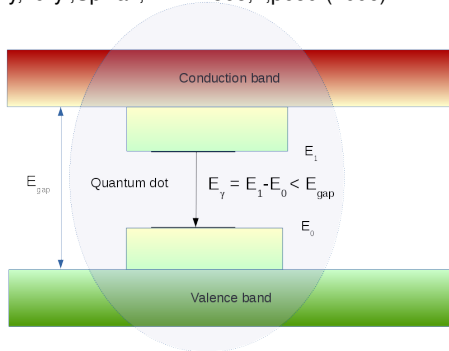
- the answer: InAs/GaAs self-assembling quantum dots
  - ▶ produced using molecular beam deposition in vacuum (MBE) at several hundred C
- lattice constants of GaAs and InAs are different
- minimization of the strain energy leads to stable nm-scale stable InAs islands - QD's
- repetitive procedure leads to a multi-layer structure



N.B. InAs/GaAs structures are grown as thin wafers (i.e, 3 inch)

## How to make created material transparent to the QD emission?

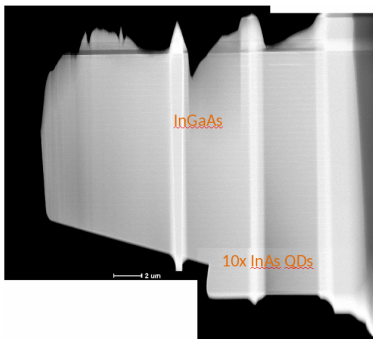
Kastalsky,Luryi,Spivak, NIM A565,2,p650 (2006)



- condition satisfied if QD's are embedded into a semiconductor bulk with  $E_{gap} > E_\gamma$ 
  - ▶ InAs QD's:  $E_\gamma \sim 1.08$  eV,  $E_{gap}^{GaAs} = 1.4$  eV
- other material choices possible, however much less investigated
- very high expectations: **light yield  $\sim 240,000$  photons/MeV, emission time  $\tau \sim 1$  ns**

## N1801 20um Scintillator: low-mag. STEM

114012 HAADF



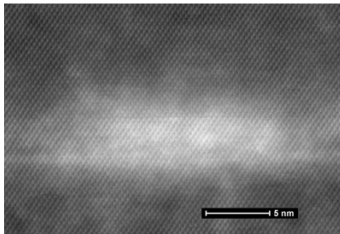
200nm p-In <sub>0.35</sub> GaAs
200nm p-In <sub>0.35</sub> GaAs
700nm i-In <sub>0.35</sub> GaAs 450C
0.2μm n-In <sub>0.35</sub> GaAs
0.1μm n-In <sub>0.35</sub> GaAs 450C
0.8μm var-buf 350C n+Al <sub>0.92-0.6</sub> In <sub>0.02-0.35</sub> Ga <sub>0.05</sub> As
0.1μm i-Al <sub>0.9</sub> Ga <sub>0.06</sub> In <sub>0.04</sub> As 350C
0.4μm n-n+GaAs 500C (var.)
0.15μm vary-Al <sub>0.3-0.1</sub> GaAs 565C
10nm p(1e17cm <sup>-3</sup> )GaAs 595C
195nm i-GaAs 595C (var.)
2ML i-AlAs 515C
2ML i-InAs QDs 515C
100nm i-GaAs 595C (var.)
95nm i-GaAs 595C
10nm p(1e17cm <sup>-3</sup> )GaAs 595C
195nm i-GaAs 595C (var.)
2ML i-AlAs 515C
2ML i-InAs QDs 515C
100nm i-GaAs 595C (var.)
0.15μm vary-Al <sub>0.3-0.1</sub> GaAs 565C
0.15μm i-GaAs 565C
0.1μm i-AlAs 565C
0.3μm i-GaAs buffer 615C
i-GaAs, SI 3"

} 49x  
19.6μm

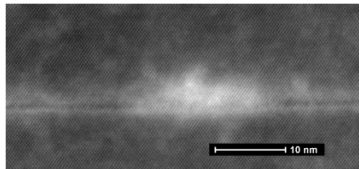
- sensors produced and characterized by our collaborators from SUNY Poly:
  - ▶ high-vacuum MBE, ~ 3" wafers
- InGaAs photodiode - integrated, processed on a sensor
- N1801: 50 layers of InAs QD's separated by 0.4 um of GaAs

# N1801 20um Scintillator: QDs, TEM, DF

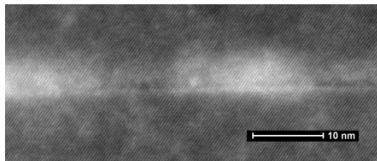
#120498HAADF



#120554-HAADF



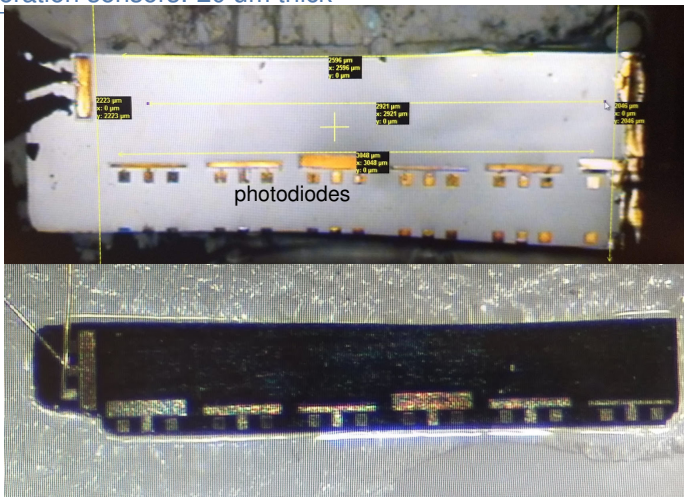
#120957-HAADF



QD diam ~ 14nm

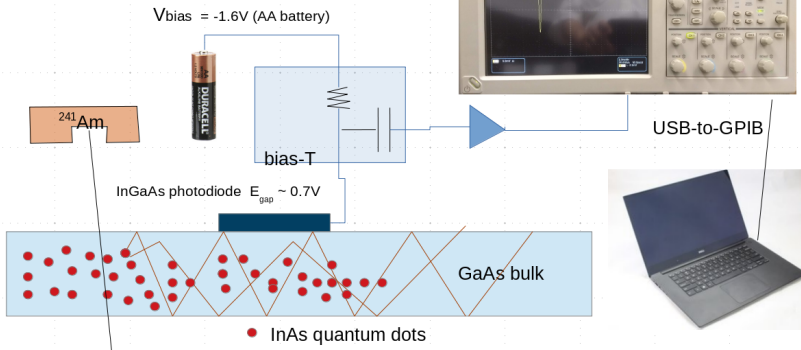
QD density (4-5) x 10<sup>10</sup> cm<sup>-2</sup>

## First generation sensors: 20 $\mu\text{m}$ thick



- gen1 sensors: 4-5 mm long ,  $\sim 1$  mm wide, 20  $\mu\text{m}$  thick - to stop a 5.5 MeV  $\alpha$ -particle
- GaAs index of refraction  $n = 3.4 \Rightarrow$  upon reflection from a plane only 2% of light exits
- expect  $\sim 90\%$  of the emitted light not to exit  $\Rightarrow$  InGaAs photodiodes integrated
- photodiodes - 500 $\mu\text{m}$  x (35 -50 - 100)  $\mu\text{m}$  x 0.7  $\mu\text{m}$  mesa

## First characterization attempt at Fermilab



- amplifiers - 1-3 stages, the total gain up to 600
- use TDS7704B (7GHz, 20Gs) as a trigger+DAQ
- read the oscilloscope over GPIB (up to a few Hz), analyze data offline

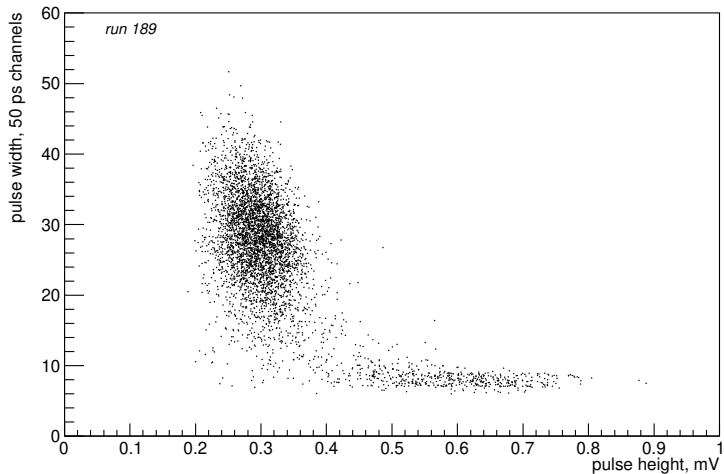


## schematics can be very misleading



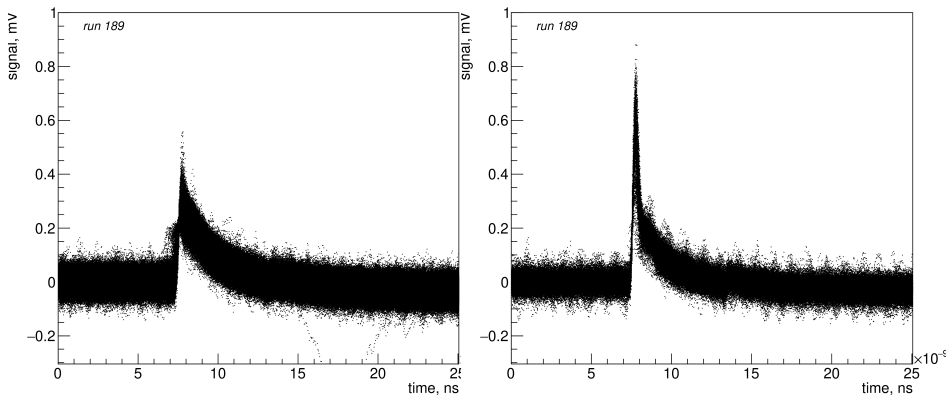
- for scintillators, goal number one - measure the energy resolution
- Am-241 5.5 MeV  $\alpha$ -particle range in the air  $\sim$  4 cm
- want the r/a source as small as possible - a \$14 smoke detector is the best bet
- the source energy resolution  $\sim$  3%, source-to-source variations at a level of 2%
- uncollimated source with the  $D=2.2$  mm  $^{241}\text{Am}$  foil

## First data



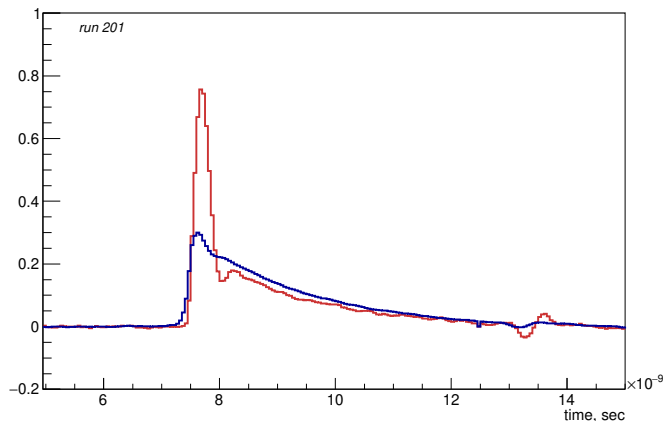
- observe two very distinct groups of pulses

## waveforms from the two groups - strikingly different



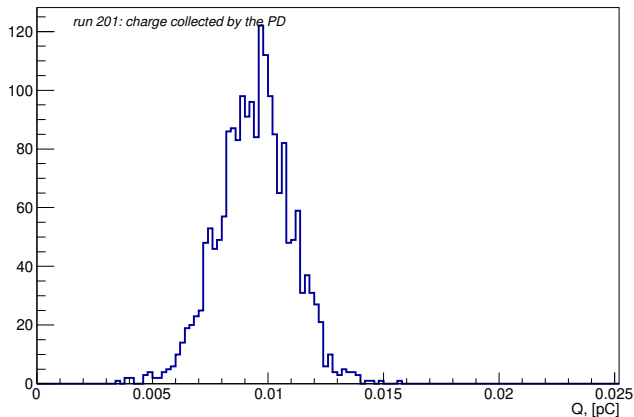
- full width of the spike (left) - about 500 ps
  - ▶ consistent with being limited by the amplifier bandwidth
- noise - 30  $\mu\text{V}$ , a  $\sim 1$  GHz pick-up seen
  - ▶ the digital oscilloscope itself is an important contributor

## Overlaying pulses of two types



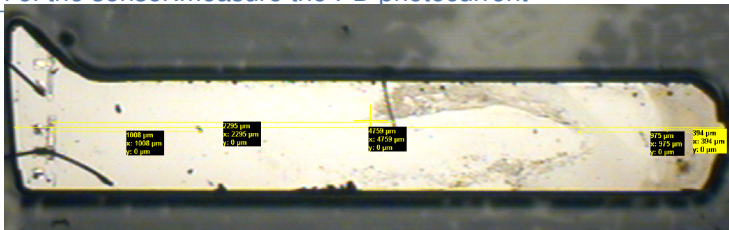
- charge in the spike consistent with the direct ionization in the  $50 \times 500 \times 0.7$   $\mu\text{m}$  PD
- pulses with spikes -  $\alpha$ 's going through the PD and stopping in the scintillator
- pulses without spikes - particles hitting the scintillator, but not the PD
- tail consistent with the QD radiative lifetime of  $\sim 1$ - $1.5$  ns

## Energy resolution for 5.5 MeV $\alpha$ -particles

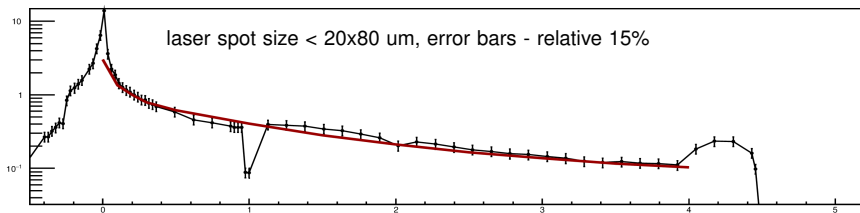


- charge on PD  $\sim 1$  pC - corresponds to collection efficiency  $\sim 8\%$
- observed energy resolution  $\sim 10$ - $15\%$  ? - expected much better even for  $8\%$  efficiency
- the sensors are  $20 \mu\text{m}$  thin - could multiple reflections in the sensor play a role ?

## Laser scan of the sensor: measure the PD photocurrent

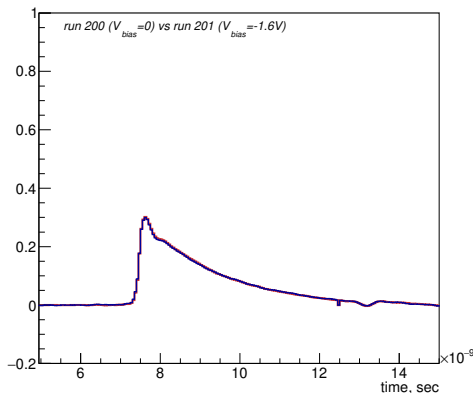
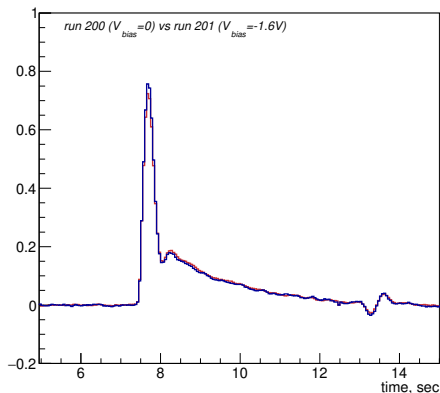


Graph



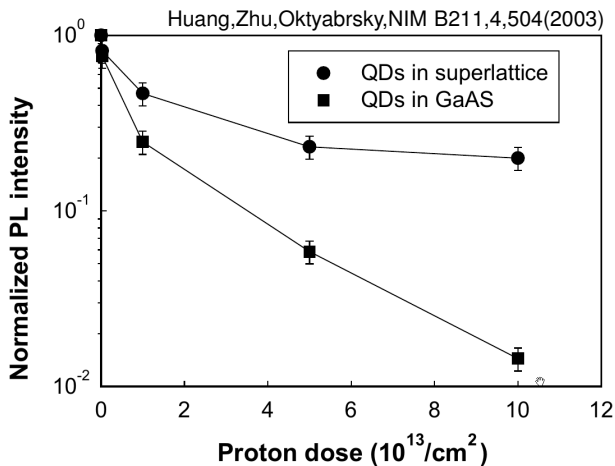
- laser scan captures the photodiode, defect, and epoxy in the end
- MC :  $\lambda_{abs} \sim 2.2 \text{ mm}$ , probability of diffuse reflection - 2.5% - good description
- geometry is important: **1 mm away from the PD the signal drops by  $\sim \times 10$**
- **photodiodes on gen1 detectors are too small for efficient detection**

## Running with zero external bias on PDs



- a p-n junction has an internal bias of the order of 1V (0.7 for Si)
- external bias of  $\sim 1V$  doesn't add much
- detector - sensor + PD - can operate in a photovoltaic mode, as a solar cell
- zero-bias mode minimizes the dark current, no shot noise

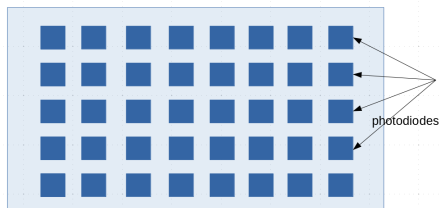
## Radiation hardness - irradiation with 1 MeV protons



- emission of InAs QD's in a 5-layer superlattice reduced by 20% after 10<sup>13</sup> protons/cm<sup>2</sup>
- 99% recovery after 5 · 10<sup>13</sup> p/cm<sup>2</sup> (~ 90 MRad) and 10 min annealing in N<sub>2</sub> at 600 deg C
- Mu2e-II: expect ~ 10<sup>12</sup> protons / cm<sup>2</sup>



## Concept of a tracking sensor: GaAs/QD sensor with PD's as pixels



- have technology producing rad-hard scintillating sensors
- sensors are produced as thin wafers with integrated photodetectors
- detect light, light propagates in all directions - could expect high “fill factor”
- coordinate resolution: 500  $\mu\text{m}$  pad  $\implies \sigma \sim 150\mu$  - adequate for many trackers
- material budget: 20  $\mu\text{m}$  GaAs  $\sim$  40  $\mu\text{m}$  Si  $\implies$  3800  $e^- h$  pairs
  - ▶ **need to read out signals corresponding to 1000 photons**
- measure signals with  $\sim$  200 ps leading edge
  - ▶ timing resolution expectations are high
  - ▶ detect photons traveling  $\sim$  1 mm, no  $\sim$  10-15 ps floor
- sensors and photodiodes may not need power

## Summary

- detectors made of semiconductor-based scintillators may quite interesting applications in HEP
- QD/GaAs -based sensors are fast, rad-hard, have integrated photodiodes
- signals from  $\alpha$ -particles have leading edge shorter than 1 ns
- photodiodes can operate without an external bias
- further R&D is needed to
  - ▶ improve light collection efficiency
  - ▶ develop low noise readout for MIP signals
- **one could think of a charged particle tracking sensors built based on this concept**